IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

n re Patent Ap	plication of:				
Kenji ABE et al	•				
Application No.	Group Art Unit: Unassigned				
Filed: July 31,	2003	Examiner: Unassigned			
For: APPAR	ATUS AND METHOD FOR CALCUL	ATING SIMULATION COVERAGE			
	INFORMATION DISCLOS	URE STATEMENT			
Commissioner PO Box 1450 Alexandria, VA Sir:					
In accordance with the duty of disclosure provisions of 37 CFR § 1.56, there is hereby provided certain information which the Examiner may consider material to the examination of the subject U.S. patent application. It is requested that the Examiner make this information of record fit is deemed material to the examination of the subject application.					
1. E	Enclosures accompanying this Inforn	nation Disclosure Statement are:			
1a. [1b. [1c. [1d. [1e. [Copy of IDS citation. An English language copy of seapplication or a PCT Internation (compact the properties of the pro	omplete or relevant portion(s)) attached to			
		a concise explanation of what is presently ach non-English language publication is			
2a. [2b. [enclosed "English-language ve indicates the degree of relevan- 609, Minimum Requirements fo	s 2a, 2b, 2c and/or 2d) sh language publications were cited on the rsion of the search report or action which ce found by the foreign office. (See MPEP or an Information Disclosure Statement, Part elevance, pp. 600-100 to 600-101, Rev. 1,			

2c. L 2d. [= '	glish language translation (complete or releva each non-English language publication. 1(e), hereto.	ınt
to be (othe	material to patentability nor rthan search report(s) from a	ormation cited in this Statement is, or is consi a representation that a search has been mad a counterpart foreign application or a PCT omitted herewith). 37 CFR §§ 1.97(g) and (h)	le
	1	Respectfully submitted,	
	,	STAAS & HALSEY LLP	
Dated:) 434-1500	By: William F. Herbert Registration No. 31,024	

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. APPLICATION NO.

1095.1281 Unassigned

FIRST NAMED INVENTOR

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

enji ABE				
LING DATE	GROUP ART UNIT			
ulv 31. 2003	Unassigned			

U.S. PATENT DOCUMENTS

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*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSI YES	LATION NO
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OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AM	English Language Abstract of Japanese Unexamined Patent Publication No. 2001-014365 published January 19, 2001.
	AN	·
	AO	

EXAMINER	DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.